

**Search Notes**

Application/Control No.

10/532,155

Examiner

Naheed Ejaz

Applicant(s)/Patent under  
Reexamination

VANDERPERREN ET AL.

Art Unit

2611

**SEARCHED**

Class	Subclass	Date	Examiner
375	130,139, 147,150, 316,322	3/13/2007	NE
375	324,326	3/13/2007	NE
375	335,340	3/13/2007	NE
375	343	3/13/2007	NE

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search attached	2/14/2007	NE
Consulted with Primary Examiner Pankaj Kumar	3/12/2007	NE
Consulted with SPE Chieh Fan	3/13/2007	NE